TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL TYPE (PCT PROCESS)

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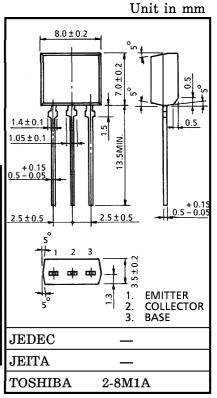
POWER AMPLIFIER APPLICATIONS

DRIVER STAGE AMPLIFIER APPLICATIONS

• High Transition Frequency: f_T=100MHz (Typ.)

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	RATING	UNIT	
Collector-Base Voltage		v_{CBO}	160	V	
Collector-Emitter Voltage		v_{CEO}	160	V	
Emitter-Base Voltage		$V_{ m EBO}$	5	V	
Collector Current	DC	$I_{\mathbf{C}}$	1.5	A	
	Pulse	I_{CP}	3		
Base Current	$I_{\mathbf{B}}$	0.15	A		
Collector Power Dissipation		$P_{\mathbf{C}}$	1.3	W	
Junction Temperature		T_{j}	150	°C	
Storage Temperature Range		$\mathrm{T_{stg}}$	-65~150	$^{\circ}\mathrm{C}$	



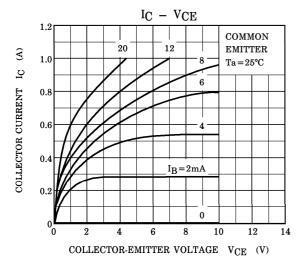
Weight: 0.55g (Typ.)

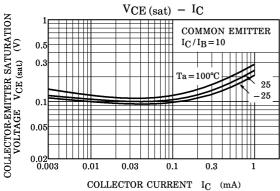
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

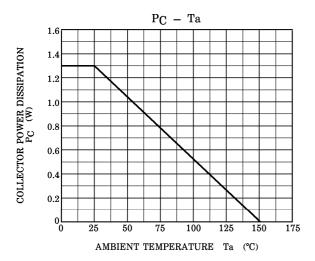
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	I_{CBO}	$V_{CB} = 160V, I_{E} = 0$	_	_	1.0	μ A
Emitter Cut-off Current	$I_{ m EBO}$	$V_{EB}=5V, I_C=0$	_	_	1.0	μ A
Collector-Emitter Breakdown Voltage	V (BR) CEO	$I_{\rm C} = 10 {\rm mA}, I_{\rm B} = 0$	160	_	_	V
DC Current Gain	hFE (Note)	$V_{CE}=5V$, $I_{C}=100mA$	70	_	240	
Collector-Emitter Saturation Voltage	V _{CE} (sat)	I _C =500mA, I _B =50mA	_	_	1.0	V
Base-Emitter Voltage	$V_{ m BE}$	$V_{CE}=5V, I_{C}=500mA$	_	0.75	0.95	V
Transition Frequency	$ m f_{ m T}$	$V_{CE} = 10V, I_{C} = 100mA$	_	100	_	MHz
Collector Output Capacitance	C_{ob}	$V_{CB} = 10V, I_{E} = 0, f = 1MHz$	_	25		pF

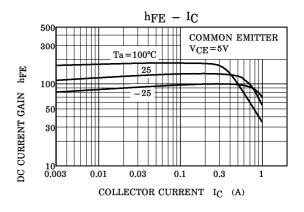
(Note): h_{FE} Classification $O: 70\sim140, Y: 120\sim240$

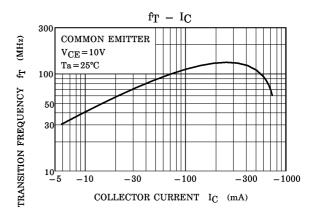
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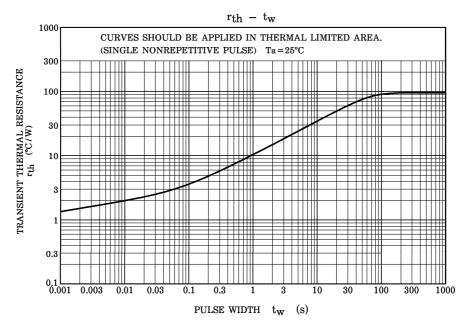


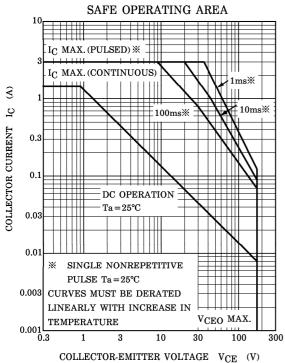






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